Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/620,911	MCCOY ET AL.
Examiner	Art Unit
Hai Tran	3694

SEARCHED				
Class	Subclass	Date	Examiner	
705	43	12/28/2007	нт	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEAR (INCLUDING SI	CH NOT)
.		DATE	EXMR
PALM Inventor search		12/28/2007	нт
EAST Tool search		12/28/2007	нт
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